

SANYO Semiconductors

DATA SHEET

An ON Semiconductor Company

ATP401 ---

N-Channel Silicon MOSFET

General-Purpose Switching Device Applications

Features

- ON-resistance $R_{DS}(on)1=2.8m\Omega(typ)$
- 4.5V Drive

- Input Capasitance Ciss=17000pF(typ)
- Halogen free compliance

Specifications

Absolute Maximum Ratings at Ta=25°C

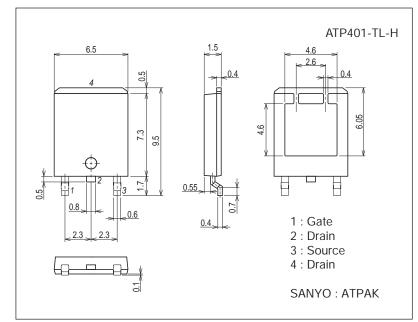
Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	VDSS		60	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	ID		100	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	400	А
Allowable Power Dissipation	PD	Tc=25°C	90	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C
Avalanche Energy (Single Pulse) *1	EAS		549	mJ
Avalanche Current *2	IAV		70	А

*1 VDD=36V, L=100 μ H, IAV=70A(Fig.1)

*2 L≤100µH, Single pulse

Package Dimensions

unit : mm (typ) 7057-001

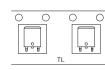


Product & Package Information

Package : ATPAK
JEITA, JEDEC :-

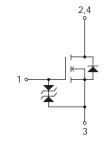
• Minimum Packing Quantity : 3,000 pcs./reel

Packing Type: TL Marking





Electrical Connection



Parameter	Symbol	Constituine and	Ratings			1.1
Parameter	Symbol	Conditions	min	typ	max	Unit
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0V	60			V
Zero-Gate Voltage Drain Current	IDSS	V _{DS} =60V, V _{GS} =0V			10	μΑ
Gate-to-Source Leakage Current	IGSS	V _{GS} =±16V, V _{DS} =0V			±10	μΑ
Cutoff Voltage	V _{GS} (off)	V _{DS} =10V, I _D =1mA	1.2		2.6	V
Forward Transfer Admittance	yfs	VDS=10V, ID=50A		90		S
Static Drain-to-Source On-State Resistance	R _{DS} (on)1	ID=50A, VGS=10V		2.8	3.7	mΩ
Static Drain-to-Source On-State Resistance	R _{DS} (on)2	ID=50A, VGS=4.5V		3.7	5.2	mΩ
Input Capacitance	Ciss			17000		pF
Output Capacitance	Coss	V _{DS} =20V, f=1MHz		1000		рF
Reverse Transfer Capacitance	Crss			770		рF
Turn-ON Delay Time	t _d (on)			110		ns
Rise Time	tr			580		ns
Turn-OFF Delay Time	t _d (off)	See Fig.2		840		ns
Fall Time	tf			710		ns
Total Gate Charge	Qg			300		nC
Gate-to-Source Charge	Qgs	V _{DS} =36V, V _{GS} =10V, I _D =100A		60		nC
Gate-to-Drain "Miller" Charge	Qgd	1		60		nC
Diode Forward Voltage	VSD	IS=100A, VGS=0V		0.9	1.2	V

Fig.1 Unclamped Inductive Switching Test Circuit

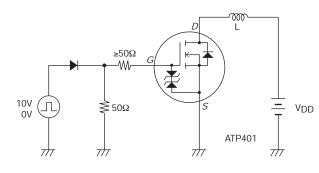
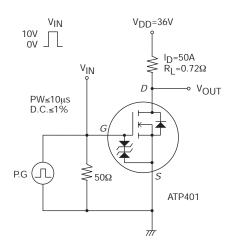
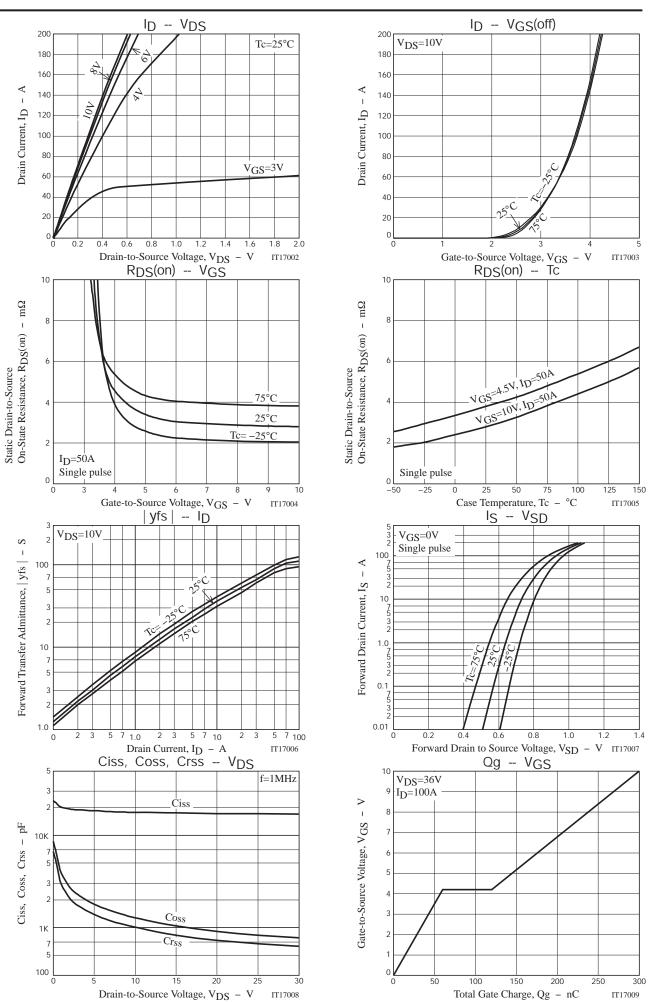


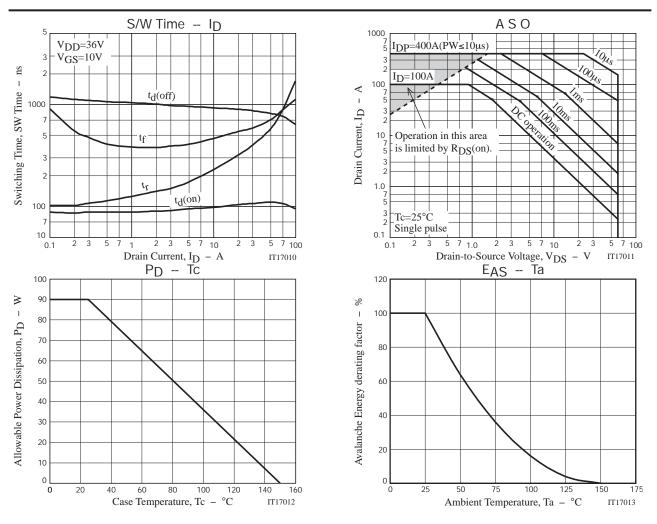
Fig.2 Switching Time Test Circuit



Ordering Information

Device	Package	Shipping	memo	
ATP401-TL-H	ATPAK	3,000pcs./reel	Pb Free and Halogen Free	

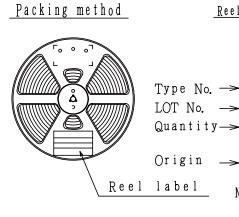




Taping Specification ATP401-TL-H

1. Packing Format (TL)

Package Name	Carrier Tape	Maximum Number of devices contained (pcs)			Packing f	o r m a t
Larvade Mame	Туре	Reel Inner box		Outer box	INNER BOX SD-C-18	OUTER BOX SD-A-18
					1 reels contained	5 inner boxes contained
ATPAK	ATP	3,000	003,000	15,000	Dimensions:mm (external)	Dimensions:mm (external)
					340×340×28	355×355×165



Reel	label, Inner box	label
	(unit:mm)	
	69	I

>

Outer box label It is a label at the time of factory shipments. The form of a label may change in physical distribution process.

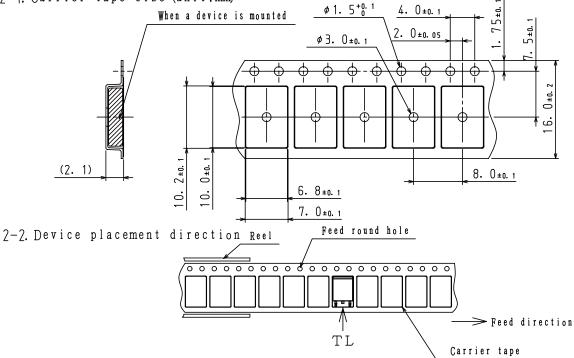
	_	108
		-
	TYPE CODE	*
	TYPB	00000000
0	QTY	0, 000 pcs (1) LEAD FREE #
8	lot	00000000
	PACKAGE	00000000
-	SPECIAL	*20722005310C*
_*	- NOORMELI !!	TTTT (DIFFORIUS: ####)

NOTE (1) The LEAD FREE * description shows that the surface treatment of the terminal is lead free.

Label	JEITA Phase		
LEAD FREE 3	JEITA Phase 3A		
LEAD FREE 4	JEITA Phase 3		

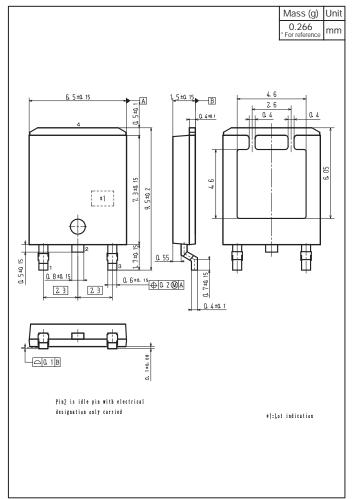
2. Taping configuration

2-1. Carrier tape size (unit:mm)

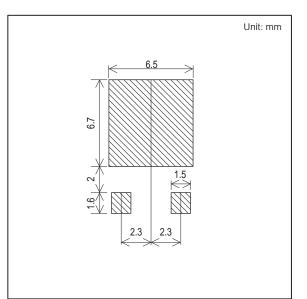


The one erectrode terminals on feed hole side ···· TL

Outline Drawing ATP401-TL-H



Land Pattern Example



Note on usage : Since the ATP401 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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